TOSHIBA Transistor Silicon PNP Epitaxial Type (PCT process)

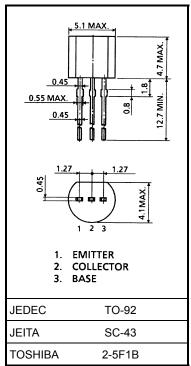
2SA1300

Strobe Flash Applications Medium Power Amplifier Applications

- High DC current gain and excellent hFE linearity $h_{\text{FE}}(1) = 140 \sim 600 \text{ (V}_{\text{CE}} = -1 \text{ V}, \text{ I}_{\text{C}} = -0.5 \text{ A}$: hFE (2) = 60 (min), 120 (typ.) (VCE = -1 V, IC = -4 A)
- Low saturation voltage: V_{CE} (sat) = -0.5 V (max) ٠ $(I_C = -2 A, I_B = -50 mA)$

Absolute Maximum Ratings (Ta = 25°C)

Characteristics		Symbol	Rating	Unit	
Collector-base voltage		V _{CBO}	-20	V	
Collector-emitter voltage		V _{CES}	-20	V	
		V _{CEO}	-10		
Emitter-base voltage		V _{EBO}	-6	V	
Collector current	DC	ΙC	-2	A	
	Pulsed (Note 1)	I _{CP}	-5		
Base current		Ι _Β	-0.2	А	
Collector power dissipation		PC	750	mW	
Junction temperature		Tj	150	°C	
Storage temperature range		T _{stg}	-55~150	°C	



Weight: 0.21 g (typ.)

Using continuously under heavy loads (e.g. the application of high temperature/current/voltage and the significant change in temperature, etc.) may cause this product to decrease in the reliability significantly even if the operating conditions (i.e. operating

temperature/current/voltage, etc.) are within the absolute maximum ratings.

Please design the appropriate reliability upon reviewing the Toshiba Semiconductor Reliability Handbook ("Handling Precautions"/"Derating Concept and Methods") and individual reliability data (i.e. reliability test report and estimated failure rate, etc).

Note 1: Pulse width = 10 ms (max), duty cycle = 30% (max)

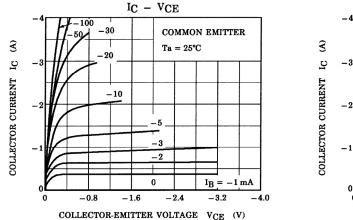
Electrical Characteristics (Ta = 25°C)

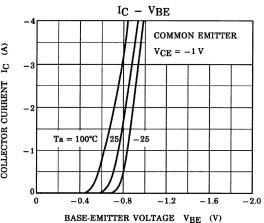
Characteristics	Symbol	Test Condition	Min	Тур.	Max	Unit
Collector cut-off current	I _{CBO}	$V_{CB} = -20 V, I_E = 0$	—	_	-0.1	μΑ
Emitter cut-off current	I _{EBO}	$V_{EB} = -6 \text{ V}, \text{ I}_{C} = 0$	_		-0.1	μA
Collector-emitter breakdown voltage	V (BR) CEO	$I_{C} = -10 \text{ mA}, I_{B} = 0$	-10	_	_	V
Emitter-base breakdown voltage	V (BR) EBO	$I_E = -1 \text{ mA}, I_C = 0$	-6	_		V
DC current gain	h _{FE (1)} (Note 2)	$V_{CE} = -1 V$, $I_C = -0.5 A$	140	_	600	
	h _{FE (2)}	$V_{CE} = -1 V, I_C = -4 A$	60	120	_	
Collector-emitter saturation voltage	V _{CE (sat)}	$I_{C} = -2 \text{ A}, I_{B} = -50 \text{ mA}$	_	-0.2	-0.5	V
Base-emitter voltage	V _{BE}	$V_{CE} = -1 V, I_C = -2 A$	_	-0.83	-1.5	V
Transition frequency	f _T	$V_{CE} = -1 \text{ V}, \text{ I}_{C} = -0.5 \text{ A}$	_	140	_	MHz
Collector output capacitance	C _{ob}	$V_{CB} = -10 \text{ V}, \text{ I}_{E} = 0, \text{ f} = 1 \text{ MHz}$	_	50	_	pF

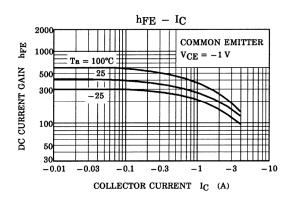
Note 2: hFE (1) classification Y: 140~280, GR: 200~400, BL: 300~600

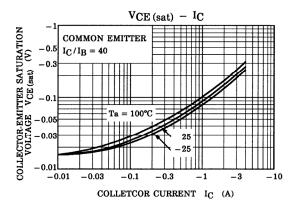
Note:

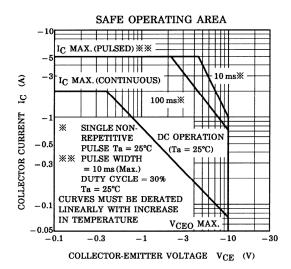
TOSHIBA

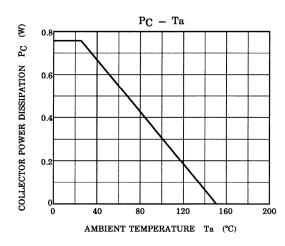












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